

**Search Notes**

Application/Control No.

10/750,606

Examiner

Raymond Phan

Applicant(s)/Patent under  
Reexamination

BOUCHIER ET AL.

Art Unit

2111

**SEARCHED**

Class	Subclass	Date	Examiner
710	306-313	2/9/2006	RP
709	201-203	2/9/2006	RP
709	217-222	2/10/2006	RP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR